



**SIEMIC, INC.**

Accessing global markets

Title: EMC Test Report for Mobile phone  
Main Model: Q50 BESTE  
Serial Model: N/A  
To: FCC Part 15 Subpart B Class B: 2012 , ANSI C63.4:2009

Report No.: 13050034-FCC-E  
Issue Date: September 16, 2013  
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## **Annex B. EUT AND TEST SETUP PHOTOGRAPHS**

### **Annex B.i. Photograph 1: EUT External Photo**



Whole Package - Top View



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EUT - Front View



EUT - Rear View



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EUT - Top View



EUT - Bottom View

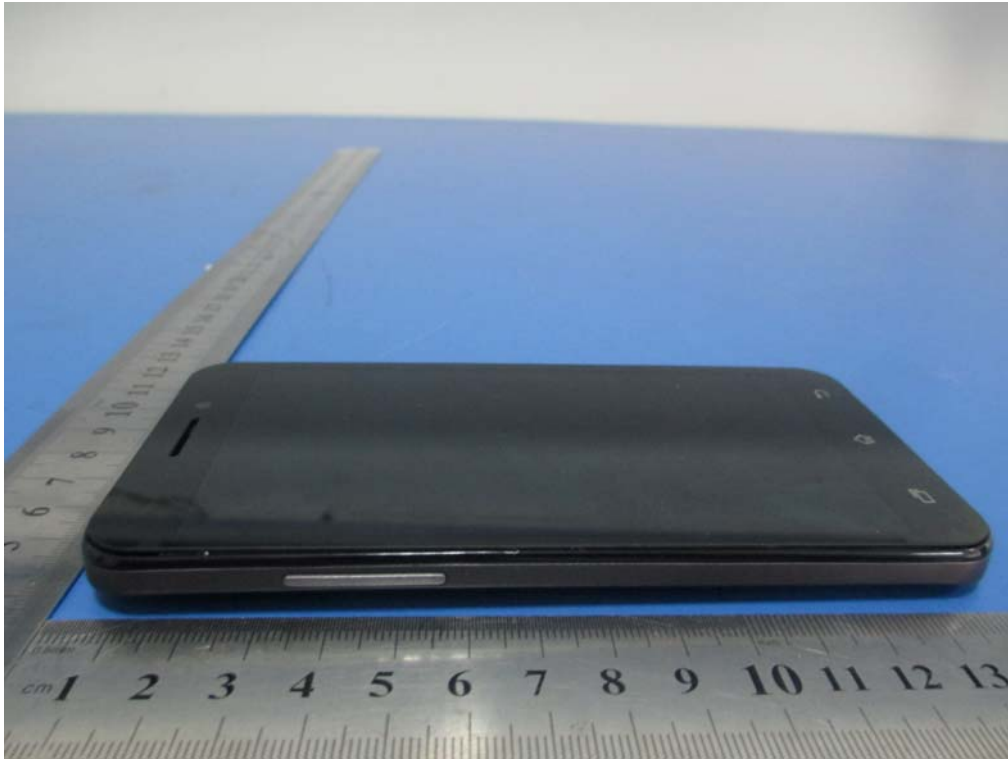


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EUT - Left View



EUT - Right View